

Notice of References Cited	Application/Control No. 10/604,057		Applicant(s)/Patent Under Reexamination SUNAGA ET AL.	
	Examiner Dang T Nguyen		Art Unit 2824	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0231523 A1	12-2003	Cho et al.	365/189.05
*	B	US-2003/0142566 A1	07-2003	Sohn et al.	365/201
*	C	US-2003/0210604 A1	11-2003	Jeong et al.	365/233
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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